Automotive DirectFET<sup>®</sup> Power MOSFET ②

- Advanced Process Technology
- Optimized for Automotive Motor Drive, DC-DC and other Heavy Load Applications
- Exceptionally Small Footprint and Low Profile
- High Power Density
- Low Parasitic Parameters
- Dual Sided Cooling
- 175°C Operating Temperature
- Repetitive Avalanche Allowed up to Tjmax
- Lead Free, RoHS Compliant and Halogen Free
- Automotive Qualified \*

0.35mΩ 0.6mΩ
545A
375nC
DirectFET2 L-can
-

## Applicable $\mathsf{DirectFET}^{\texttt{®}}$ Outline and Substrate Outline

SB	SC		M2	M4	L4	L6	L8	
Decerintic								

#### Description

The AUIRF8739L2 combines the latest Automotive HEXFET® Power MOSFET Silicon technology with the advanced DirectFET® packaging technology to achieve exceptional performance in a package that has the footprint of an SO-8 or 5X6mm PQFN and only 0.7mm profile. The DirectFET® package is compatible with existing layout geometries used in power applications, PCB assembly equipment and vapor phase, infra-red or convection soldering techniques, when application note AN-1035 is followed regarding the manufacturing methods and processes. The DirectFET® package allows dual sided cooling to maximize thermal transfer in automotive power systems.

This HEXFET® Power MOSFET is designed for applications where efficiency and power density are of value. The advanced DirectFET® packaging platform coupled with the latest silicon technology allows the AUIRF8739L2 to offer substantial system level savings and performance improvement specifically in motor drive, DC-DC and other heavy load applications on ICE, HEV and EV platforms. This MOSFET utilizes the latest processing techniques to achieve ultra low on-resistance per silicon area. Additional features of this MOSFET are 175°C operating junction temperature and high repetitive peak current capability. These features combine to make this MOSFET a highly efficient, robust and reliable device for high current automotive applications.

Base Part Number	Package Type	Standard	Orderable Part Number	
		Form	Quantity	
AUIRF8739L2	DirectFET®	Tape and Reel	4000	AUIRF8739L2TR

#### **Absolute Maximum Ratings**

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only; and functional operation of the device at these or any other condition beyond those indicated in the specifications is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability. The thermal resistance and power dissipation ratings are measured under board mounted and still air conditions. Ambient temperature (TA) is 25°C, unless otherwise specified.

	Parameter	Max.	Units
V <sub>DS</sub>	Drain-to-Source Voltage	40	V
I <sub>D</sub> @ T <sub>C</sub> = 25°C	Continuous Drain Current, V <sub>GS</sub> @ 10V ④	545	
I <sub>D</sub> @ T <sub>C</sub> = 100°C	Continuous Drain Current, V <sub>GS</sub> @ 10V ④	385	
I <sub>D</sub> @ T <sub>A</sub> = 25°C	Continuous Drain Current, V <sub>GS</sub> @ 10V ③	57	А
I <sub>D</sub> @ T <sub>C</sub> = 25°C	Continuous Drain Current, V <sub>GS</sub> @ 10V (Package limit)	375	
I <sub>DM</sub>	Pulsed Drain Current ©	1150	
P <sub>D</sub> @T <sub>C</sub> = 25°C	Power Dissipation ④	340	14/
P <sub>D</sub> @T <sub>A</sub> = 25°C	Power Dissipation ③	3.8	W
E <sub>AS</sub>	Single Pulse Avalanche Energy (Thermally Limited) ⑥	312	mJ
E <sub>AS</sub> (Tested)	Single Pulse Avalanche Energy	1500**	
I <sub>AR</sub>	Avalanche Current ©	See Fig. 14, 15, 22a, 22b	А
E <sub>AR</sub>	Repetitive Avalanche Energy ©		
Τ <sub>Ρ</sub>	Peak Soldering Temperature	270	mJ
TJ	Operating Junction and	-55 to + 175	°C
T <sub>STG</sub>	Storage Temperature Range		Ċ

\*Qualification standards can be found at http://www.irf.com/

## **Thermal Resistance**

Symbol	Parameter		Тур.	Max.	Units
R <sub>0JA</sub>	Junction-to-Ambient ③			40	
R <sub>0JA</sub>	Junction-to-Ambient ®		12.5		
R <sub>0JA</sub>					°C/W
R <sub>θJ-Can</sub>	Junction-to-Can ④⑩	0.44			
R <sub>0J-PCB</sub>	Junction-to-PCB Mounted			0.5	
	Linear Derating Factor ④			2.3	W/°C

# Static Electrical Characteristics @ $T_J$ = 25°C (unless otherwise specified)

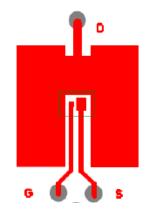
Parameter	Min.	Тур.	Max.	Units	Conditions
Drain-to-Source Breakdown Voltage	40			V	V <sub>GS</sub> = 0V, I <sub>D</sub> = 250µA
Breakdown Voltage Temp. Coefficient		0.03		V/°C	Reference to 25°C, I <sub>D</sub> = 5.0mA
Static Drain-to-Source On-Resistance		0.35	0.60	mΩ	V <sub>GS</sub> = 10V, I <sub>D</sub> = 195A ⑦
Gate Threshold Voltage	2.2		3.9	V	$V_{DS} = V_{GS}, I_D = 250 \mu A$
Gate Threshold Voltage Coefficient		-12		mV/°C	
Forward Transconductance	250			S	V <sub>DS</sub> = 10V, I <sub>D</sub> = 195A
Internal Gate Resistance		0.81		Ω	
Durain to Course Lookana Current			1.0		$V_{DS} = 40V, V_{GS} = 0V$
Drain-to-Source Leakage Current			150	μΑ	$V_{DS} = 40V, V_{GS} = 0V, T_{J} = 125^{\circ}C$
Gate-to-Source Forward Leakage			100		V <sub>GS</sub> = 20V
Gate-to-Source Reverse Leakage			-100	nA	V <sub>GS</sub> = -20V
	Drain-to-Source Breakdown VoltageBreakdown Voltage Temp. CoefficientStatic Drain-to-Source On-ResistanceGate Threshold VoltageGate Threshold Voltage CoefficientForward TransconductanceInternal Gate ResistanceDrain-to-Source Leakage CurrentGate-to-Source Forward Leakage	Drain-to-Source Breakdown Voltage       40         Breakdown Voltage Temp. Coefficient       —         Static Drain-to-Source On-Resistance       —         Gate Threshold Voltage       2.2         Gate Threshold Voltage Coefficient       —         Forward Transconductance       250         Internal Gate Resistance       —         Drain-to-Source Leakage Current       —         Gate-to-Source Forward Leakage       —	Drain-to-Source Breakdown Voltage40Breakdown Voltage Temp. CoefficientBreakdown Voltage Temp. Coefficient0.03Static Drain-to-Source On-ResistanceGate Threshold Voltage2.2Gate Threshold Voltage Coefficient12Forward Transconductance250Internal Gate Resistance0.81Drain-to-Source Leakage CurrentGate-to-Source Forward Leakage	Drain-to-Source Breakdown Voltage40Breakdown Voltage Temp. Coefficient0.03Static Drain-to-Source On-Resistance0.350.60Gate Threshold Voltage2.23.9Gate Threshold Voltage Coefficient12Forward Transconductance250Internal Gate Resistance0.81Drain-to-Source Leakage Current1.0Gate-to-Source Forward Leakage100	Drain-to-Source Breakdown Voltage40VBreakdown Voltage Temp. Coefficient $0.03$ V/°CStatic Drain-to-Source On-Resistance $0.35$ $0.60$ m $\Omega$ Gate Threshold Voltage2.2 $3.9$ VGate Threshold Voltage Coefficient $-12$ mV/°CForward Transconductance250SSInternal Gate Resistance $0.81$ SDrain-to-Source Leakage Current $1.0$ $\mu A$ Gate-to-Source Forward Leakage $100$ $n A$

### Dynamic Electrical Characteristics @ T<sub>J</sub> = 25°C (unless otherwise specified)

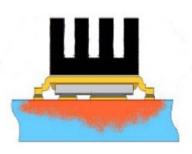
Symbol	Parameter	Min.	Тур.	Max.	Units	Conditions
Q <sub>g</sub>	Total Gate Charge		375	562		V <sub>DS</sub> = 20V
Q <sub>gs1</sub>	Gate-to-Source Charge		60			V <sub>GS</sub> = 10V
Q <sub>gs2</sub>	Gate-to-Source Charge		40		nC	I <sub>D</sub> = 195A
Q <sub>gd</sub>	Gate-to-Drain ("Miller") Charge		120			
Q <sub>godr</sub>	Gate Charge Overdrive		155			
Q <sub>sw</sub>	Switch Charge (Q <sub>gs2</sub> + Q <sub>gd</sub> )		160			
Q <sub>oss</sub>	Output Charge		151		nC	$V_{DS} = 32V, V_{GS} = 0V$
t <sub>d(on)</sub>	Turn-On Delay Time		34			V <sub>DD</sub> = 20V, V <sub>GS</sub> = 10V ⑦
t <sub>r</sub>	Rise Time		117			I <sub>D</sub> = 195A
t <sub>d(off)</sub>	Turn-Off Delay Time		120		ns	R <sub>G</sub> = 1.8Ω
t <sub>f</sub>	Fall Time		95			
C <sub>iss</sub>	Input Capacitance		17890			V <sub>GS</sub> = 0V
C <sub>oss</sub>	Output Capacitance		2640			V <sub>DS</sub> = 25V
C <sub>rss</sub>	Reverse Transfer Capacitance		1830		pF	<i>f</i> = 500 kHz
C <sub>oss</sub> eff.	Effective Output Capacitance		3785			$V_{GS} = 0V, V_{DS} = 0V \text{ to } 32V$

### **Diode Characteristics**

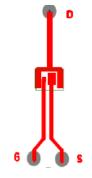
Symbol	Parameter	Min.	Тур.	Max.	Units	Conditions
	Continuous Source Current			545	۸	MOSFET symbol
I <sub>S</sub>	(Body Diode)				A	showing the
	Pulsed Source Current			1150		integral reverse 🔍 🛄
I <sub>SM</sub>	(Body Diode) ⑤				A	p-n junction diode.
V <sub>SD</sub>	Diode Forward Voltage			1.2	V	$T_J$ = 25°C, $I_S$ = 195A, $V_{GS}$ = 0V $\odot$
t <sub>rr</sub>	Reverse Recovery Time		47		ns	I <sub>F</sub> = 195A, V <sub>DD</sub> = 20V
Q <sub>rr</sub>	Reverse Recovery Charge		66		nC	dv/dt = 100A/µs ⊘



③ Surface mounted on 1 in. square Cu board (still air).



 Mounted to a PCB with small clip heatsink (still air)



 Mounted on minimum footprint full size board with metalized back and with small clip heatsink (still air).



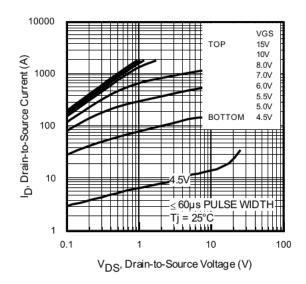


Fig. 1 Typical Output Characteristics

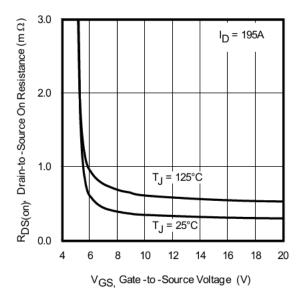


Fig. 3 Typical On-Resistance vs. Gate Volt-

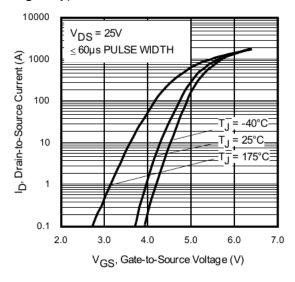


Fig 5. Transfer Characteristics

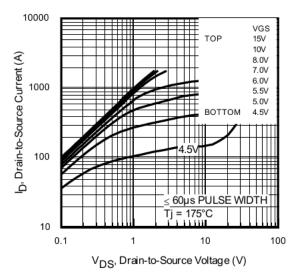


Fig. 2 Typical Output Characteristics

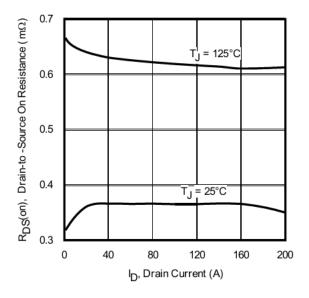


Fig. 4 Typical On-Resistance vs. Drain Current

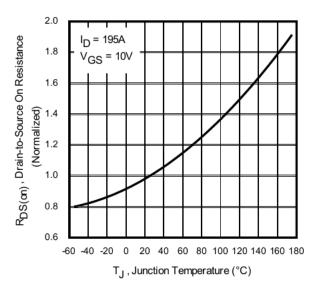
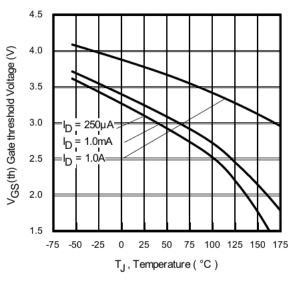


Fig 6. Normalized On-Resistance vs. Temperature







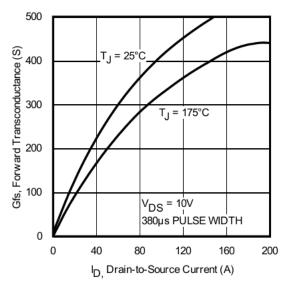


Fig 9. Typical Forward Transconductance vs. Drain Cur-

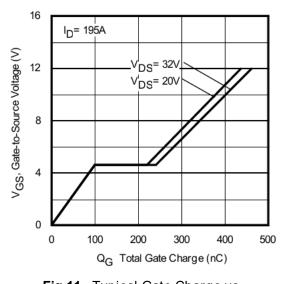
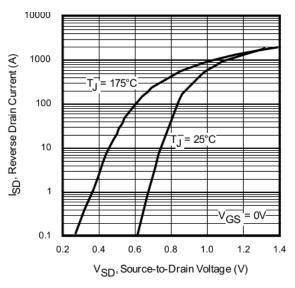


Fig 11. Typical Gate Charge vs. Gate-to-Source Voltage





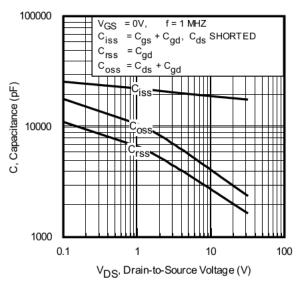


Fig 10. Typical Capacitance vs. Drain-to-Source Volt-

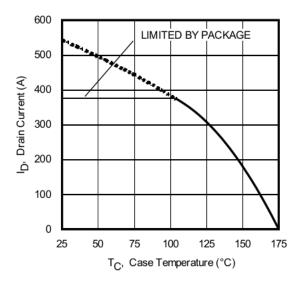


Fig 12. Maximum Drain Current vs. Case Temperature

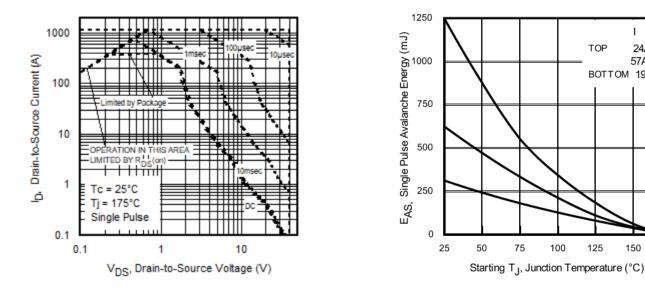


TOP

I D

24A

57A BOTTOM 195A



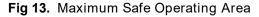


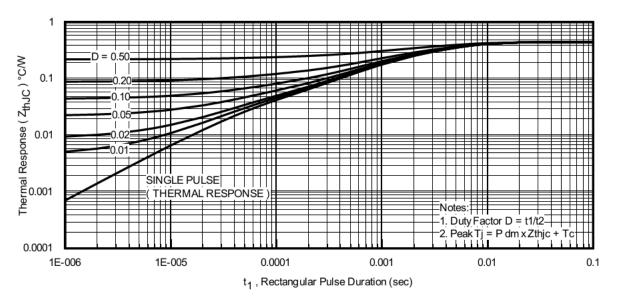
Fig 14. Maximum Avalanche Energy vs. Temperature

100

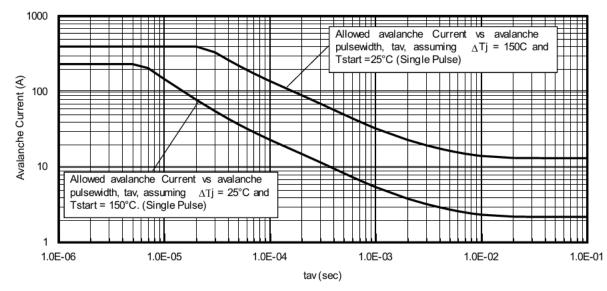
125

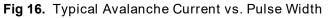
150

175

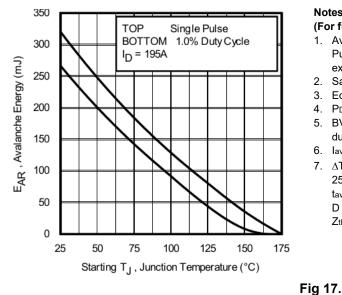












## Notes on Repetitive Avalanche Curves , Figures 16, 17:

- (For further info, see AN-1005 at www.irf.com) 1. Avalanche failures assumption:
  - Purely a thermal phenomenon and failure occurs at a temperature far in excess of T<sub>jmax</sub>. This is validated for every part type.
- Safe operation in Avalanche is allowed as long as Tjmax is not exceeded.
- 3. Equation below based on circuit and waveforms shown in Figures 18a, 18b.
- 4. PD (ave) = Average power dissipation per single avalanche pulse.
- 5. BV = Rated breakdown voltage (1.3 factor accounts for voltage increase during avalanche).
- 6. Iav = Allowable avalanche current.
- 7.  $\Delta T$  = Allowable rise in junction temperature, not to exceed T<sub>jmax</sub> (assumed as 25°C in Figure 16, 17).
  - tav = Average time in avalanche.
  - D = Duty cycle in avalanche =  $t_{av} \cdot f$

ZthJC(D, tav) = Transient thermal resistance, see Figures 15)

$$\begin{split} \textbf{P}_{D (ave)} &= 1/2 \text{ ( } \textbf{1.3} \cdot \textbf{BV} \cdot \textbf{I}_{av} \text{)} = \Delta T / \textbf{Z}_{thJC} \\ \textbf{I}_{av} &= 2 \Delta T / \text{ [ } \textbf{1.3} \cdot \textbf{BV} \cdot \textbf{Z}_{th} \text{]} \\ \textbf{E}_{AS (AR)} &= \textbf{P}_{D (ave)} \cdot \textbf{t}_{av} \end{split}$$

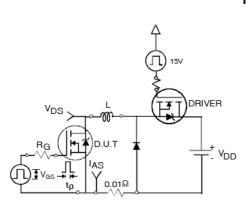


Fig 18a. Unclamped Inductive Test Circuit

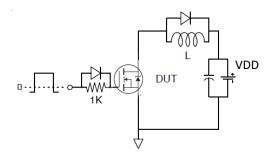


Fig 19a. Gate Charge Test Circuit

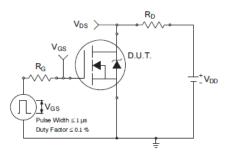
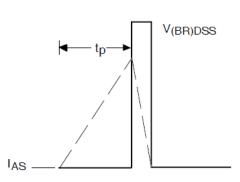


Fig 20a. Switching Time Test Circuit





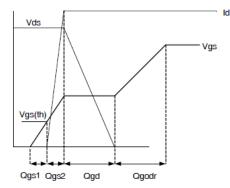


Fig 19b. Gate Charge Waveform

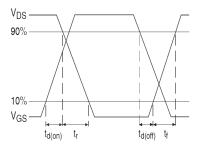
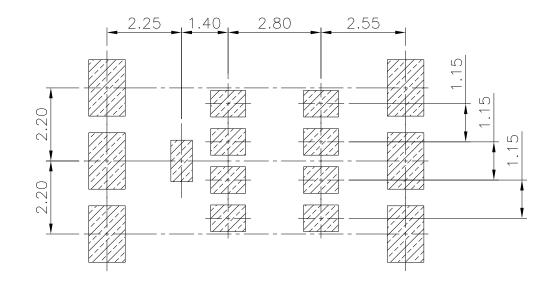


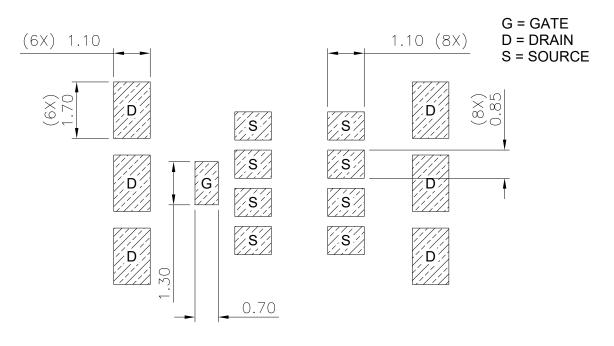
Fig 20b. Switching Time Waveforms



# DirectFET<sup>®</sup> Board Footprint, L8 Outline (Large Size Can, 8-Source Pads)

Please see DirectFET application note AN-1035 for all details regarding the assembly of DirectFET. This includes all recommendations for stencil and substrate designs.



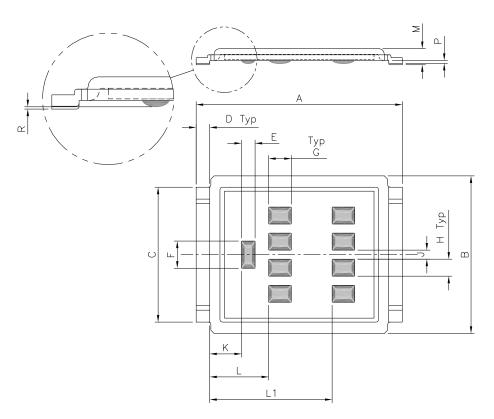


Note: For the most current drawing please refer to IR website at http://www.irf.com/package/



# DirectFET<sup>®</sup> Outline Dimension, L8 Outline (Large Size Can, 8-Source Pads)

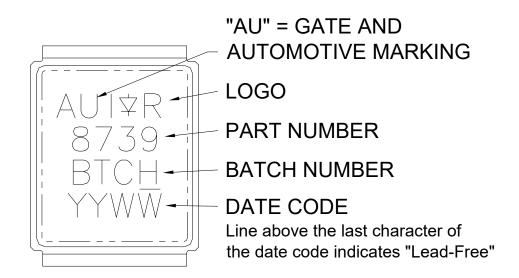
Please see DirectFET application note AN-1035 for all details regarding the assembly of DirectFET. This includes all recommendations for stencil and substrate designs.



DIMENSIONS								
METRIC IMPERIAL								
	=	RIC	IMPE	RIAL				
CODE	MIN	MAX	MIN	MAX				
Α	9.05	9.15	0.356	0.360				
В	6.85	7.10	0.270	0.280				
С	5.90	6.00	0.232	0.236				
D	0.55	0.65	0.022	0.026				
Е	0.58	0.62	0.023	0.024				
F	1.18	1.22	0.046	0.048				
G	0.98	1.02	0.039	0.040				
Н	0.73	0.77	0.029	0.030				
J	0.38	0.42	0.015	0.017				
к	1.35	1.45	0.053	0.057				
L	2.55	2.65	0.100	0.104				
L1	5.35	5.45	0.211	0.215				
М	0.68	0.74	0.027	0.029				
Р	0.09	0.17	0.003	0.007				
R	0.02	0.08	0.001	0.003				

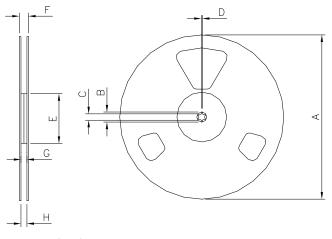
Dimensions are shown in millimeters (inches)

# DirectFET<sup>®</sup> Part Marking



Note: For the most current drawing please refer to IR website at http://www.irf.com/package/

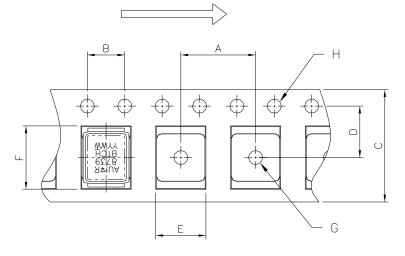
## DirectFET<sup>®</sup> Tape & Reel Dimension (Showing component orientation)



NOTE: Controlling dimensions in mm Std reel quantity is 4000 parts, ordered as AUIRF8739L2TR.

REEL DIMENSIONS						
STANDARD OPTION (QTY 4000)						
	MET	RIC	IMPE	RIAL		
CODE	MIN	MAX	MIN	MAX		
Α	330.00	N.C	12.992	N.C		
В	20.20	N.C	0.795	N.C		
С	12.80	13.20	0.504	0.520		
D	1.50	N.C	0.059	N.C		
E	99.00	100.00	3.900	3.940		
F	N.C	22.40	N.C	0.880		
G	16.40	18.40	0.650	0.720		
Н	15.90	19.40	0.630	0.760		

#### LOADED TAPE FEED DIRECTION



		DI	MENSION	٧S	
		MET	FRIC	IMPE	RIAL
NOTE: CONTROLLING DIMENSIONS IN MM	CODE	MIN	MAX	MIN	MAX
	А	11.90	12.10	4.69	0.476
	В	3.90	4.10	0.154	0.161
	С	15.90	16.30	0.623	0.642
	D	7.40	7.60	0.291	0.299
	E	7.20	7.40	0.283	0.291
	F	9.90	10.10	0.390	0.398
	G	1.50	N.C	0.059	N.C
	Н	1.50	1.60	0.059	0.063

Note: For the most current drawing please refer to IR website at http://www.irf.com/package/

# **Qualification Information<sup>†</sup>**

		Automotive (per AEC-Q101)			
Qualificat	ion Level	Comments: This part number(s) passed Automotive qualification. IF Industrial and Consumer qualification level is granted by extension of t higher Automotive level.			
Moisture S	Sensitivity Level	DirectFET2 L-CAN MSL1			
	Machine Model	Class M4 (+/- 800V) <sup>††</sup>			
			AEC-Q101-002		
ESD	Human Body Model	Class H2 (+/- 4000V) <sup>††</sup>			
			AEC-Q101-001		
RoHS Compliant		Yes			

† Qualification standards can be found at International Rectifier's web site: http://www.irf.com/

†† Highest passing voltage.

## **Revision History**

Date	Rev.	Comments
02/17/2015	2.0	Final data sheet
06/15/2022	2.1	<ul> <li>Update Fig.13_SOA curve</li> <li>Corrected typo on Absolute Maximum Ratings Table from "VGS" to "VDS" on page 1</li> </ul>

- ① Click on this section to link to the appropriate technical paper.
- <sup>(2)</sup> Click on this section to link to the DirectFET<sup>®</sup> Website.
- $\ensuremath{\textcircled{}}$  Surface mounted on 1 in. square Cu board, steady state.
- ④ T<sub>c</sub> measured with thermocouple mounted to top (Drain) of part.
- S Repetitive rating; pulse width limited by max. junction temperature.
- $\ensuremath{\textcircled{}^{\circ}}$  Starting T\_J = 25°C, L = 0.016mH, R\_G = 50 $\Omega$ , I\_{AS} = 195A, Vgs = 20V.
- $\oslash~$  Pulse width  $\leq 400 \mu s;~ duty~ cycle \leq 2\%.$
- Ised double sided cooling, mounting pad with large heatsink.
- Mounted on minimum footprint full size board with metalized back and with small clip heatsink.
- 0 R<sub> $\theta$ </sub> is measured at T<sub>J</sub> of approximately 90°C.
- \*\* Starting T\_J = 25°C, L = 0.1mH, R\_G = 50 $\Omega$ , I<sub>AS</sub> = 288A, Vgs = 20V

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#### WORLD HEADQUARTERS:

101 N. Sepulveda Blvd., El Segundo, California 90245

Tel: (310) 252-7105